ABSTRACT

An eye diagram is an important parameter in automotive applications. Good eye performance is beneficial for applications like CarPlay™, Android Auto™, and CarLife™. This application report discusses the influence of the TPS254x series devices on eye performance in automotive systems, and how to improve the eye performance.

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CarLife is a trademark of Baidu.
Android Auto is a trademark of Google, Inc.
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1 Introduction

The TPS254x series devices are host controllers that support USB2.0 communication, while providing overcurrent protection, overtemperature protection, cable compensation, short-to-battery protection, and more. Figure 1 shows a typical application of TPS254X devices in an automotive system.

![Figure 1. TPS254x Typical Application Circuit](image)
Impact of TPS254x on System Eye Performance

Being interconnected, the TPS254x device impacts the eye performance of the system, due to the parasitic resistance and capacitance of internal circuits in the TPS254x. Figure 2 and Figure 3 show a comparison of one system before and after connecting the TPS254900 device. From the eye diagram test results, we see that the rising edge rate becomes slightly slower after connecting the TPS254900 device.

Figure 2. Eye Diagram Without TPS254900

Figure 3. Eye Diagram With TPS254900
The higher the bandwidth of the TPS254x, the lower the impact on eye performance. The TPS2546 device has the highest bandwidth in the TPS254x series products; TPS254900 has a higher bandwidth than TPS2549. Table 1 lists the –3 dB bandwidth of the TPS254x series products.

**Table 1. TPS254x Device Bandwidth**

<table>
<thead>
<tr>
<th>Part Number</th>
<th>Bandwidth (GHz)</th>
</tr>
</thead>
<tbody>
<tr>
<td>TPS2546</td>
<td>2.6</td>
</tr>
<tr>
<td>TPS254900</td>
<td>0.940</td>
</tr>
<tr>
<td>TPS2549</td>
<td>0.925</td>
</tr>
</tbody>
</table>

Table 2 lists the eye diagram test results of the TPS2546, TPS254900, and TPS2549 devices. From the test results, we know that the TPS2546 device has the best eye performance, due to its highest bandwidth.

**Table 2. Eye Diagram Test Results of TPS2546, TPS2549, and TPS254900**

<table>
<thead>
<tr>
<th>Part Number</th>
<th>Eye Diagram</th>
<th>Rising Edge Rate</th>
<th>Falling Edge Rate</th>
</tr>
</thead>
<tbody>
<tr>
<td>TPS2546</td>
<td><img src="image1.png" alt="Eye Diagram" /></td>
<td>877.77 V / µs</td>
<td>874.51 V / µs</td>
</tr>
<tr>
<td>TPS254900</td>
<td><img src="image2.png" alt="Eye Diagram" /></td>
<td>832.88 V / µs</td>
<td>830.53 V / µs</td>
</tr>
<tr>
<td>TPS2549</td>
<td><img src="image3.png" alt="Eye Diagram" /></td>
<td>785.57 V / µs</td>
<td>783.08 V / µs</td>
</tr>
</tbody>
</table>
3 Improving Eye Diagram Performance

3.1 Improving Source Drive Capability

Figure 4 to Figure 7 show the impact of the source amplitude on the TPS2549 eye diagram. A higher amplitude source signal results in a more open eye. In actual applications, customers can configure the registers of the host controller to adjust the signal amplitude.

![Figure 4. TPS2549 Source Impact (Lower Amplitude)](image1)

![Figure 5. TPS2549 Source Impact Eye Diagram (Lower Amplitude)](image2)

![Figure 6. TPS2549 Source Impact (Higher Amplitude)](image3)

![Figure 7. TPS2549 Source Impact Eye Diagram (Higher Amplitude)](image4)
3.2 Using Inductors and Capacitors to Improve Eye Performance

Figure 8 shows the LC network diagram used to improve the system eye performance. Figure 9 shows the test results before and after connecting the LC network.

Figure 8. Connect Inductor in Data Lines

Figure 9. Eye Diagram With and Without LC Network
3.3 Bypassing TPS254x to Improve Eye Performance

Figure 10 and Figure 11 show two ways to bypass the TPS254x device. In these methods, the TPS254x only implements BC1.2 primary detection and secondary detection. The eye performance will be improved because the TPS254x device is not connected in the data lines.

![Figure 10. Bypass DP_IN and DM_IN](image)

![Figure 11. Bypass DP_OUT and DM_OUT](image)
Table 3 shows a comparison of the TPS254900 eye diagram when connected and bypassed.

Table 3. TPS254900 Eye Diagram Connected and Bypassed

<table>
<thead>
<tr>
<th>TPS254900 Status</th>
<th>Rising Edge Rate</th>
<th>Falling Edge Rate</th>
</tr>
</thead>
<tbody>
<tr>
<td>Connected</td>
<td>862.90 V / µs</td>
<td>915.84 V / µs</td>
</tr>
<tr>
<td>Bypassed</td>
<td>902.54 V / µs</td>
<td>900.24 V / µs</td>
</tr>
</tbody>
</table>

Figure 12 and Figure 13 show the eye diagrams of the TPS254900 in connected and bypassed states.

Figure 12. TPS254900 Connected

Figure 13. TPS254900 Bypassed
3.4 Using Redrivers to Improve Eye Performance

Another effective way to improve eye performance is to add a redriver. The TUSB211 device is a USB, high-speed signal conditioner designed to compensate for ISI signal loss in a transmission channel. Figure 14 shows the test results of the TPS2549 eye diagram before and after connecting the TUSB211, based on the real PCB of the customer.

![Figure 14. Eye Diagram With and Without TUSB211](image)

However, eye diagram performance is a system-level parameter. Eye diagram performance can be influenced by the host controller, PCB routes, cables, USB connectors, common chokes, TVS, and so on. Any negligence of these factors will result in bad eye performance. Some recommendations when designing a system follow:

- Route D+ and D– as differential pairs according to the USB2.0 specification.
- The differential impedance from D+ and D– routes to ground must be 90 Ω.
- Ensure the ground plane is not split, to ensure continuity of differential impedance.
- Route the D+ and D– lines as short as possible to minimize the voltage drop and parasitic inductance.
- Minimize the use of vias in the D+ and D– data lines.
- Use certified cables and USB connectors.

4 References

- Texas Instruments, TPS2549 USB Charging Port Controller and Power Switch With Cable Compensation, data sheet
- Texas Instruments, TPS254900-Q1 Automotive USB Host Charger With Short-to-VBATT Protection, data sheet
- Texas Instruments, TUSB211 USB 2.0 High Speed Signal Conditioner, data sheet
- Texas Instruments, TPS254xEVM-064, user’s guide
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